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TRANSMITTAL OF RESPONSE			Docket No. 3430-0131P	
In re Application of: Kwar	g-Jo HWANG	·		
Application No. 09/648,111	Filing Date August 25, 2000		aminer Richards	Group Art Unit 2815
Invention: METHOD OF	PATTERNING A METAL LAY	'ER IN A SEI	MICONDUCTOR	R DEVICE
	TO THE COMMISSIONER	OF PATEN	<u>TS:</u>	
	esponse in this application, ir 17, 2006. This Response co 7 C.F.R. 41.37.			
The fee for the extension  A check in the amount of This sheet is submitte  Payment by credit car  The Director is hereby credit any overpayme This sheet is submitte	Small Entity  n of time is also enclosed.  of time is  t of is  t the fee to Deposit Account No.  d in duplicate.  d. Form PTO-2038 is attached authorized to charge any adnt to Deposit Account No.	enclosed. lo. 02 ed. ditional fees 02-244	2-2448 that may be req	
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# MS APPEAL BRIEF - PATENTS PATENT 3430-0131P

#### IN THE U.S. PATENT AND TRADEMARK OFFICE

In Re Application of

Before the Board of Appeals

Kwang-Jo Hwang

Appeal No.

Appl. No.:

09/648,111

Group:

2815

Filed:

August 25, 2000

Examiner:

N.D. Richards

Conf. No.:

5562

For:

METHOD OF PATTERNING A METAL LAYER IN A

SEMICONDUCTOR DEVICE

## RESPONSE TO NOTIFICATION OF NON-COMPLIANT BRIEF (37 C.F.R. 41.37)

### MS APPEAL BRIEF- PATENTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

September 15, 2006

Dear Sir:

In response to the Notice of Non-Compliant Appeal Brief mailed August 17, 2006, the applicant respectfully submits the appended Summary of Claimed Subject Matter in accordance with 37 C.F.R 41.37. The appended Summary of Claimed Subject Matter contains a precise explanation of the subject matter defined in each of the independent claims involved in the appeal and refers to the figures by reference numeral.

A replacement Appeal Brief is not being filed pursuant to MPEP 1205.03, which states: "When the Office holds the brief to be defective solely due to appellant's failure to

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provide a summary of the claimed subject matter as required by 37 CFR 41.37 (c)(1)(v), an entire new brief need not, and should not, be filed. Rather, a paper providing a summary of the claimed subject matter as required by 37 CFR 41.37 (c)(1)(v) will suffice."

If necessary, the Commissioner is hereby authorized in this, concurrent, and further replies, to charge payment or credit any overpayment to Deposit Account No. 02-2448 for any additional fee required under 37 C.F.R. § 1.16 or under 37 C.F.R. § 1.17; particularly, extension of time fees.

September 15, 2006

Respectfully submitted,

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APPENDIX: SUMMARY OF CLAIMED SUBJECT MATTER

### V. SUMMARY OF CLAIMED SUBJECT MATTER

Claim 1: As set forth in independent claim 1, the present invention pertains to a method of manufacturing a liquid crystal display device that includes forming a switching element on a substrate 31 (e.g., page 4, line 5 of the present specification); forming a passivation layer 37 over the substrate 31 (e.g., page 4, lines 5-6); depositing a metal layer 44 on the passivation layer 37 (e.g., page 5, line 6); forming a photoresist pattern 36 on a surface of the metal layer 44, such that an upper portion of the metal layer is exposed (e.g., page 5, lines 7-8). The method also includes treating the exposed portion of the metal layer 44 with a first plasma, prior to any step of etching the photoresist pattern 36, and prior to any step of etching the metal layer 44, thereby lowering an internal binding force in the exposed portion of the metal layer 44 to increase the subsequent etch rate of the metal layer 44 (e.g., page 6, line 15 to page 7, line 8). Etching the treated portion of the metal layer forms a pixel electrode 39 (e.g., page 4. lines 9-10, page 7, lines 5-6). Also, the depositing of a metal layer 44 on the passivation layer 37, forming a photoresist pattern 36, and treating the exposed portion of the metal layer 44 are sequentially performed (e.g., page 6, lines 8-14). (Figures 5, 6A and 6B).

Claim 22: As set forth in independent claim 22, the present invention pertains to a method of patterning a metal layer 44 that includes the steps of depositing a metal layer 44 over a substrate 31 (page 3, line 15); forming a mask 36 on a surface of the metal layer 44 (page 3, line 15), leaving an upper portion of the metal layer 44 uncovered (page 3, line 16); exposing the uncovered portion of the metal layer 44 to a first plasma (page 3, lines 16-17), prior to any step of etching the metal layer 44, thereby lowering an internal binding force (page 3, line 17) in the uncovered portion (page 3, line 17) to increase a

subsequent etch rate of the metal layer 44 (page 7, lines 4-8); and etching the uncovered

portion of the metal layer 44 with a second plasma to form a metal pattern (page 3, lines

18-19), wherein the depositing a metal layer 44 over a substrate 31, forming a mask 36 on

a surface of the metal layer 44, and exposing the uncovered portion of the metal layer 44

are sequentially performed (Page 6, lines 8-21). (Figures 5, 6A and 6B).

Claim 30: As set forth in independent claim 30, the present invention pertains

to a method manufacturing a pixel electrode in a liquid crystal display device that

includes the steps of depositing a metal layer 44 on a passivation layer 37 which partially

covers a transistor 32, 34, 35 (page 3, lines 21-22); forming a photoresist pattern 36 on a

surface of the metal layer 44, leaving an upper portion of the metal layer 44 uncovered

(page 3, lines 22-23); exposing the uncovered portion of the metal layer 44 to at least one

first gas (page 3, line 23 to page 4, line 1), prior to any step of etching the photoresist

pattern 36 and prior to any step of etching the metal layer 44 (page 7, lines 2-5), to lower

an internal binding force in the uncovered portion to increase a subsequent etch rate of

the metal layer 44 (page 7, lines 4-8); and etching the uncovered portion of the metal

layer 44 with at least one second gas to form a pixel electrode 39 (page 7, lines 4-5),

wherein the depositing a metal layer on the passivation layer 37, forming a photoresist

pattern 36, and exposing the uncovered portion of the metal layer 44 are sequentially

performed (Page 6, lines 8-21). (Figures 5, 6A and 6B).

Claim 31: As set forth in independent claim 31, the present invention pertains to a

method of manufacturing a pixel electrode 39 in a liquid crystal display device that

includes the steps of depositing a metal layer 44 on a passivation layer 37 which partially

covers a transistor 32, 34, 35 (page 3, lines 21-22); forming a photoresist pattern 36 on a

surface of the metal layer 44, leaving an upper portion of the metal layer 44 uncovered (page 3, lines 22-23); exposing the uncovered portion of the metal layer 44 to at least one first gas (page 3, line 23 to page 4, line 1), prior to any step of etching, to lower an internal binding force in the uncovered portion to increase a subsequent etch rate of the metal layer 44 (page 7, lines 4-8); and etching the uncovered portion of the metal layer 44 with at least one second gas to form a pixel electrode 36 (page 7, lines 4-5, wherein the depositing a metal layer 44 on the passivation layer 37, forming a photoresist pattern 36, and exposing the uncovered portion of the metal layer 44 are sequentially performed(Page 6, lines 8-21). (Figures 5, 6A and 6B).